Operation of Single-Chip MOSFET and IGBT Devices after failure due to repetitive avalanche [Electronic resource] Blinov, Andrei; Norrga, Staffan; Tibola, Gabriel EPE'15 ECCE Europe: 8-10 September 2015, Geneva, Switzerland: 17th European Conference on Power Electronics and Applications 2015 / p. 1-9: ill. [USB] http://dx.doi.org/10.1109/EPE.2015.7309190